Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination
10/669,496	CHANG ET AL.
Examiner	**Art Unit**
Vuthe Siek	2825

SEARCHED			
Class	Subclass	Date	Examiner
716	2-6,7-8	3/1/2805	VS

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
716	46	1/12/06	VS
See Interference Search History Printout		1/12/06	VS

SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
EAST ALL DATABASES	3/28/2005	VS
EAST all databases See Search History Printout	10/22/05	VS
EAST all databases See search history Printout	1/12/05	VS
Updated search See Printouts EAST & IEEE	7/27/06	VS